

New Generation of WICOP

## High-Power LED - WICOP Y11

**S1Wx-1111xxxxxx-00000000-00001**



## Product Brief

### Description

- The WICOP series is designed for high flux output applications with high current operation capability.
- Compact footprint(1.14x1.14mm) enables system level cost saving
- It incorporates state of the art SMD design and low thermal resistant material.
- The WICOP is ideal light sources for directional lighting applications such as Spot Lights, various outdoor applications, automotive lightings and high performance torches .

### Features and Benefits

- Designed for high current operation
- Low Thermal Resistance
- A wide CCT range of 2,600~7,000K
- ANSI compliant Binning
- RoHS compliant
- Phosphor film directly attached to chip surface

### Key Applications

- Residential - Replacement lamps
- Commercial/Industrial – Retail Display
- Outdoor area - Flood/Street light, High Bay

**Table 1-1. Product Selection Table**

Reference Code	CCT	Nominal CCT	Part Number	CRI	Voltage
				Min	
SZ8-Y11-W0-C7-A	Cool White	6500K	S1W0-1111657003-00000000-00001	70	3V
		5700K	S1W0-1111577003-00000000-00001		
		5000K	S1W0-1111507003-00000000-00001		
SZ8-Y11-WN-C7-A	Neutral White	4000K	S1W0-1111407003-00000000-00001		
SZ8-Y11-W0-C8-A	Cool White	6500K	S1W0-1111658003-00000000-00001	80	3V
		5700K	S1W0-1111578003-00000000-00001		
		5000K	S1W0-1111508003-00000000-00001		

**Table 1-2. Product Selection Table**

Reference Code	CCT	Nominal CCT	Part Number	CRI	Voltage
				Min	
SZ8-Y11-WN-C8-A	Neutral White	4000K	S1W0-1111408003-00000000-00001	80	3V
		3500K	S1W0-1111358003-00000000-00001		
		3000K	S1W0-1111308003-00000000-00001		
SZ8-Y11-WW-C8-A	Warm White	2700K	S1W0-1111278003-00000000-00001	80	3V
		6500K	S1W0-1111659003-00000000-00001		
		5700K	S1W0-1111579003-00000000-00001		
SZ8-Y11-W0-C9-A	Cool White	5000K	S1W0-1111509003-00000000-00001	80	3V
		4000K	S1W0-1111409003-00000000-00001		
		3500K	S1W0-1111359003-00000000-00001		
SZ8-Y11-WW-C9-A	Warm White	3000K	S1W0-1111309003-00000000-00001	90	3V
		2700K	S1W0-1111279003-00000000-00001		
		6500K	S1WM-1111658006-00000000-00001		
SZ8-Y11-W0-C8-B	Cool White	5700K	S1WM-1111578006-00000000-00001	80	6V
		5000K	S1WM-1111508006-00000000-00001		
		4000K	S1WM-1111408006-00000000-00001		
SZ8-Y11-WN-C8-B	Neutral White	3500K	S1WM-1111358006-00000000-00001	80	6V
		3000K	S1WM-1111308006-00000000-00001		
		2700K	S1WM-1111278006-00000000-00001		
SZ8-Y11-WW-C8-B	Warm White	3500K	S1WM-1111359006-00000000-00001	90	6V
		3000K	S1WM-1111309006-00000000-00001		
		2700K	S1WM-1111279006-00000000-00001		
SZ8-Y11-WW-C9-B	Warm White	6500K	S1WM-1111658009-00000000-00001	80	9V
		5700K	S1WM-1111578009-00000000-00001		
		5000K	S1WM-1111508009-00000000-00001		
SZ8-Y11-W0-C8-C	Cool White	4000K	S1WM-1111408009-00000000-00001	80	9V
		3500K	S1WM-1111358009-00000000-00001		
		3000K	S1WM-1111308009-00000000-00001		
SZ8-Y11-WN-C8-C	Neutral White	2700K	S1WM-1111278009-00000000-00001	90	9V
		3500K	S1WM-1111359009-00000000-00001		
		3000K	S1WM-1111309009-00000000-00001		
SZ8-Y11-WW-C8-C	Warm White	2700K	S1WM-1111279009-00000000-00001	90	9V
		3500K	S1WM-1111359009-00000000-00001		
		3000K	S1WM-1111309009-00000000-00001		
SZ8-Y11-WW-C9-C	Warm White	2700K	S1WM-1111279009-00000000-00001	90	9V
		3500K	S1WM-1111359009-00000000-00001		
		3000K	S1WM-1111309009-00000000-00001		

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## Performance Characteristics

**Table 2-1. Electro Optical Characteristics,  $I_F=150\text{mA}$ ,  $T_J=85^\circ\text{C}$  (3V)**

Min. CRI, $R_a^{[4]}$	Nominal CCT [K] <sup>[1]</sup>	Min. Flux [lm]	Typ. Luminous Flux $\Phi_V$ <sup>[3]</sup> [lm]	Typ. Luminous Efficacy [lm/W]	Part Number
70	6500	68	72	173	S1W0-1111657003-00000000-00001
	5700	68	72	173	S1W0-1111577003-00000000-00001
	5000	68	72	173	S1W0-1111507003-00000000-00001
	4000	68	72	173	S1W0-1111407003-00000000-00001
80	6500	60	63	151	S1W0-1111658003-00000000-00001
	5700	60	63	151	S1W0-1111578003-00000000-00001
	5000	60	62	149	S1W0-1111508003-00000000-00001
	4000	60	62	149	S1W0-1111408003-00000000-00001
	3500	56	61	146	S1W0-1111358003-00000000-00001
	3000	56	61	146	S1W0-1111308003-00000000-00001
	2700	56	61	146	S1W0-1111278003-00000000-00001
90	6500	56	61	146	S1W0-1111659003-00000000-00001
	5700	56	61	146	S1W0-1111579003-00000000-00001
	5000	52	56	134	S1W0-1111509003-00000000-00001
	4000	52	56	134	S1W0-1111409003-00000000-00001
	3500	49	52	124	S1W0-1111359003-00000000-00001
	3000	49	52	124	S1W0-1111309003-00000000-00001
	2700	46	49	117	S1W0-1111279003-00000000-00001

**Notes :**

(1) Correlated Color Temperature is derived from the CIE 1931 Chromaticity diagram.

Color coordinate :  $\pm 0.005$ , CCT  $\pm 5\%$  tolerance.

(2) Seoul Semiconductor maintains a tolerance of  $\pm 7\%$  on flux and power measurements.

(3)  $\Phi_V$  is the total luminous flux output as measured with an integrating sphere.

(4) Tolerance is  $\pm 2.0$  on CRI measurements.

## Performance Characteristics

**Table 2-2. Electro Optical Characteristics,  $I_F=175\text{mA}$ ,  $T_J=85^\circ\text{C}$  (6V)**

Min. CRI, $R_a^{(4)}$	Nominal CCT [K] <sup>[1]</sup>	Min. Flux [lm]	Typ. Luminous Flux $\Phi_V$ <sup>[3]</sup> [lm]	Typ. Luminous Efficacy [lm/W]	Part Number
80	6500	116	124	124	S1WM-1111658006-00000000-00001
	5700	116	126	125	S1WM-1111578006-00000000-00001
	5000	116	126	125	S1WM-1111508006-00000000-00001
	4000	125	130	129	S1WM-1111408006-00000000-00001
	3500	125	130	129	S1WM-1111358006-00000000-00001
	3000	116	124	124	S1WM-1111308006-00000000-00001
	2700	116	124	124	S1WM-1111278006-00000000-00001
90	3500	102	109	108	S1WM-1111359006-00000000-00001
	3000	96	105	105	S1WM-1111309006-00000000-00001
	2700	96	105	105	S1WM-1111279006-00000000-00001

**Notes :**

(1) Correlated Color Temperature is derived from the CIE 1931 Chromaticity diagram.

Color coordinate :  $\pm 0.005$ , CCT  $\pm 5\%$  tolerance.

(2) Seoul Semiconductor maintains a tolerance of  $\pm 7\%$  on flux and power measurements.

(3)  $\Phi_V$  is the total luminous flux output as measured with an integrating sphere.

(4) Tolerance is  $\pm 2.0$  on CRI measurements.

## Performance Characteristics

**Table 2-3. Electro Optical Characteristics,  $I_F=115\text{mA}$ ,  $T_J=85^\circ\text{C}$  (9V)**

Min. CRI, $R_a^{[4]}$	Nominal CCT [K] <sup>[1]</sup>	Min. Flux [lm]	Typ. Luminous Flux $\Phi_V$ <sup>[3]</sup> [lm]	Typ. Luminous Efficacy [lm/W]	Part Number
80	6500	125	133	133	S1WM-1111658009-00000000-00001
	5700	125	133	133	S1WM-1111578009-00000000-00001
	5000	125	133	133	S1WM-1111508009-00000000-00001
	4000	116	125	125	S1WM-1111408009-00000000-00001
	3500	116	125	125	S1WM-1111358009-00000000-00001
	3000	109	115	115	S1WM-1111308009-00000000-00001
	2700	109	115	115	S1WM-1111278009-00000000-00001
90	3500	96	102	102	S1WM-1111359009-00000000-00001
	3000	96	102	102	S1WM-1111309009-00000000-00001
	2700	96	102	102	S1WM-1111279009-00000000-00001

**Notes :**

(1) Correlated Color Temperature is derived from the CIE 1931 Chromaticity diagram.

Color coordinate :  $\pm 0.005$ , CCT  $\pm 5\%$  tolerance.

(2) Seoul Semiconductor maintains a tolerance of  $\pm 7\%$  on flux and power measurements.

(3)  $\Phi_V$  is the total luminous flux output as measured with an integrating sphere.

(4) Tolerance is  $\pm 2.0$  on CRI measurements.

## Performance Characteristics

**Table 3. Absolute Maximum Ratings**

Parameter	Symbol	Value			Unit
		Min.	Typ.	Max.	
Forward Current	$I_F$	-	150	700	mA
		-	175	350	
		-	115	230	
Power Dissipation	$P_D$	-	-	2.28	W
Junction Temperature	$T_j$	-	-	145	°C
Storage Temperature	$T_{stg}$	- 40	-	125	°C
Viewing angle	$\theta$		150		degree
Thermal resistance (J to S) <sup>[2]</sup>	$R\theta_{J-S}$	-	10 <sup>[3]</sup>	-	K/W
ESD Sensitivity(HBM)		Class 2 JEDEC JS-001-2017			

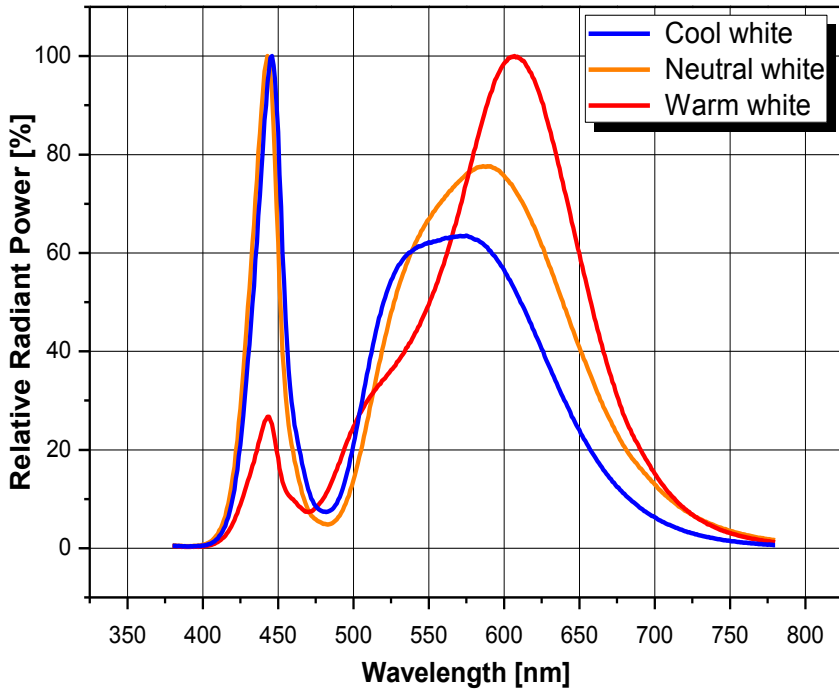
**Notes :**

- (1) At Junction Temperature 85°C condition.
- (2)  $R\theta_{J-S}$  is tested at typical forward current.
- (3) Using Metal PCB (Normal type).

- Thermal resistance can be increased substantially depending on the heat sink design/operating condition, and the maximum possible driving current will decrease accordingly.

# Characteristics Graph

## Color Spectrum



(Fig 1)

## Typical Spatial Distribution

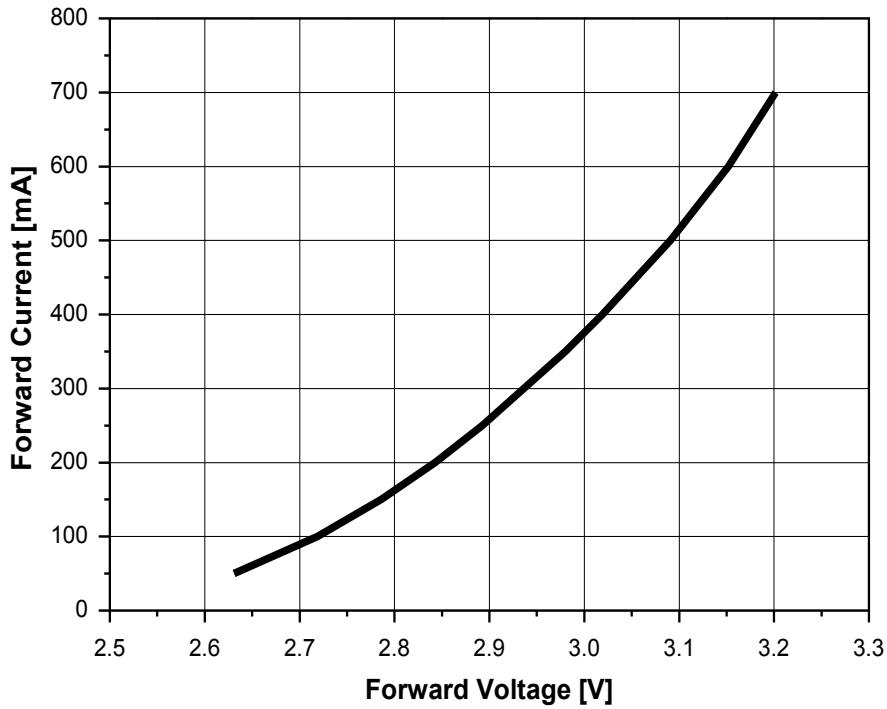


(Fig 2)



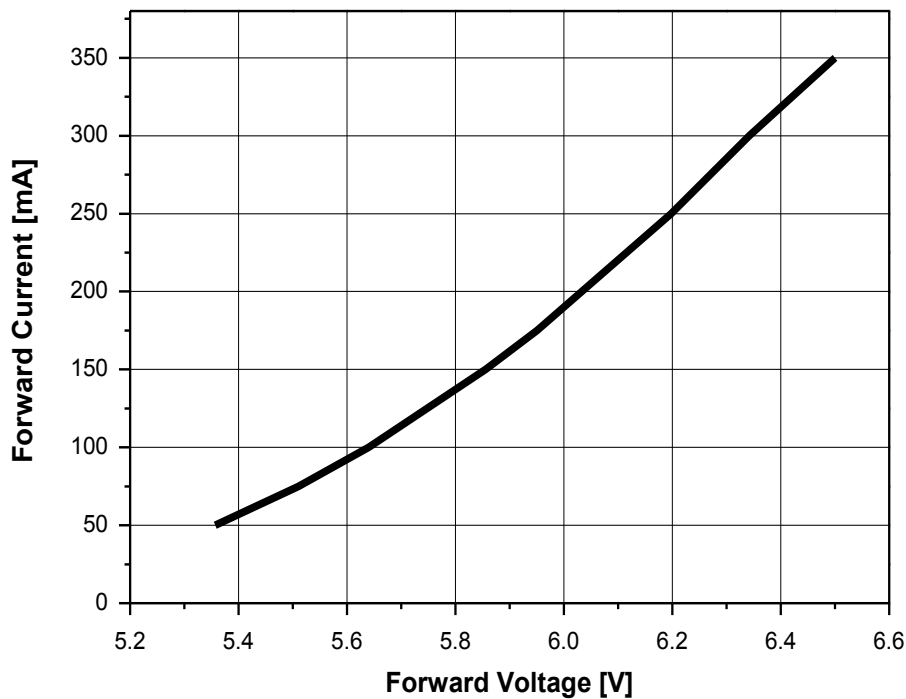
## Characteristics Graph

Forward Voltage vs. Forward Current,  $T_j=85^{\circ}\text{C}$  (3V)



(Fig 3-1)

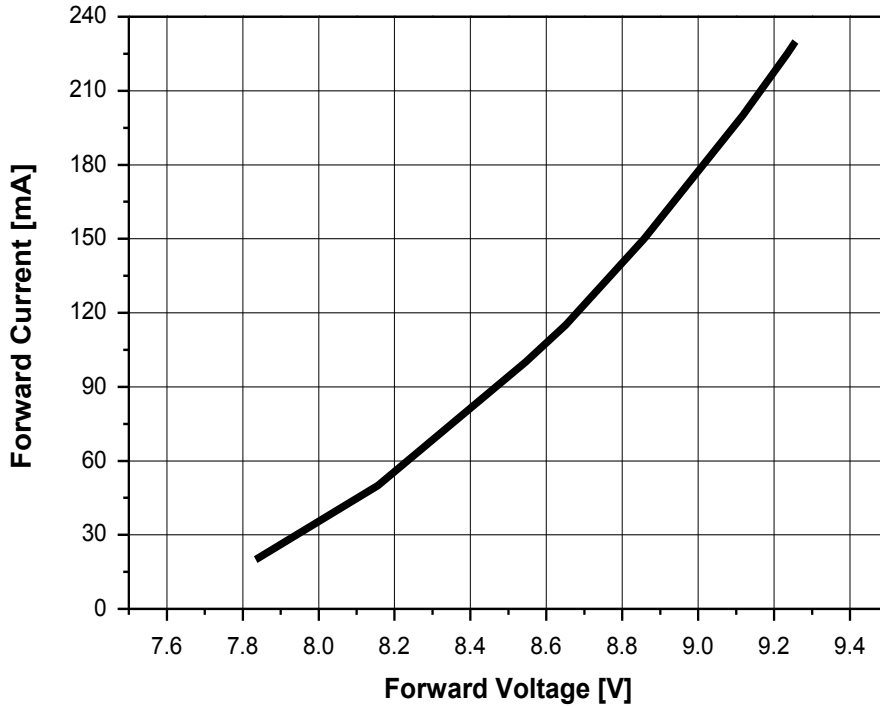
Forward Voltage vs. Forward Current,  $T_j=85^{\circ}\text{C}$  (6V)



(Fig 3-2)

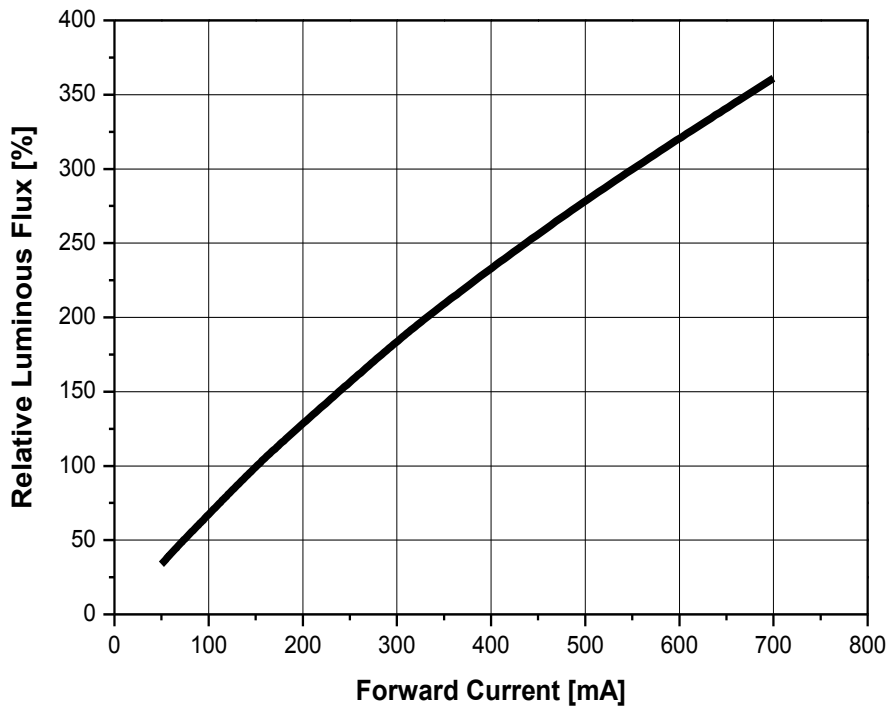
## Characteristics Graph

Forward Voltage vs. Forward Current,  $T_j=85^\circ\text{C}$  (9V)



(Fig 3-3)

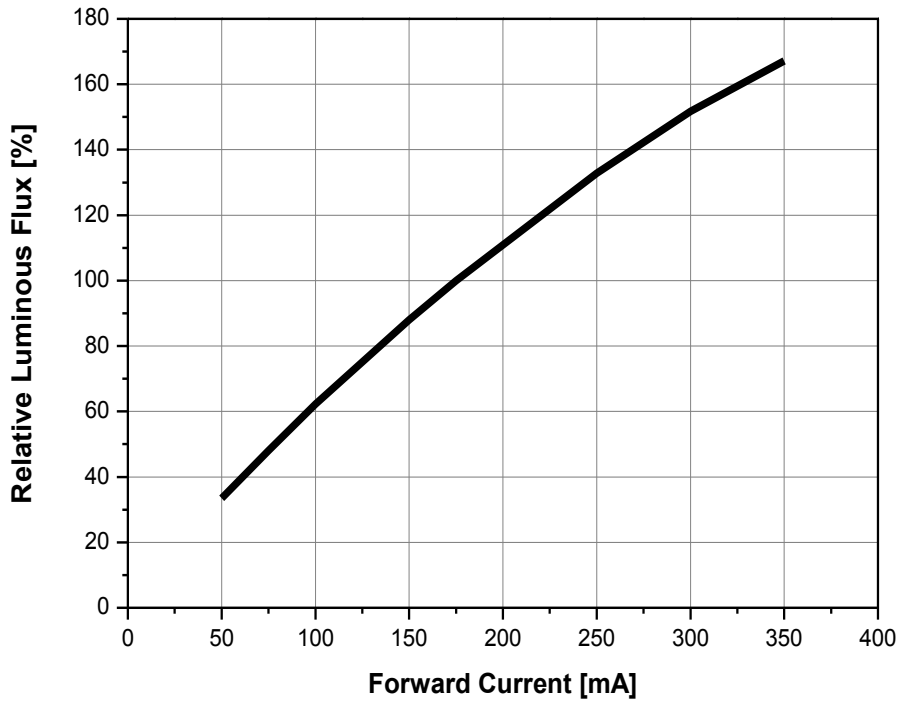
Forward Current vs. Relative Luminous Flux,  $T_j=85^\circ\text{C}$  (3V)



(Fig 4-1)

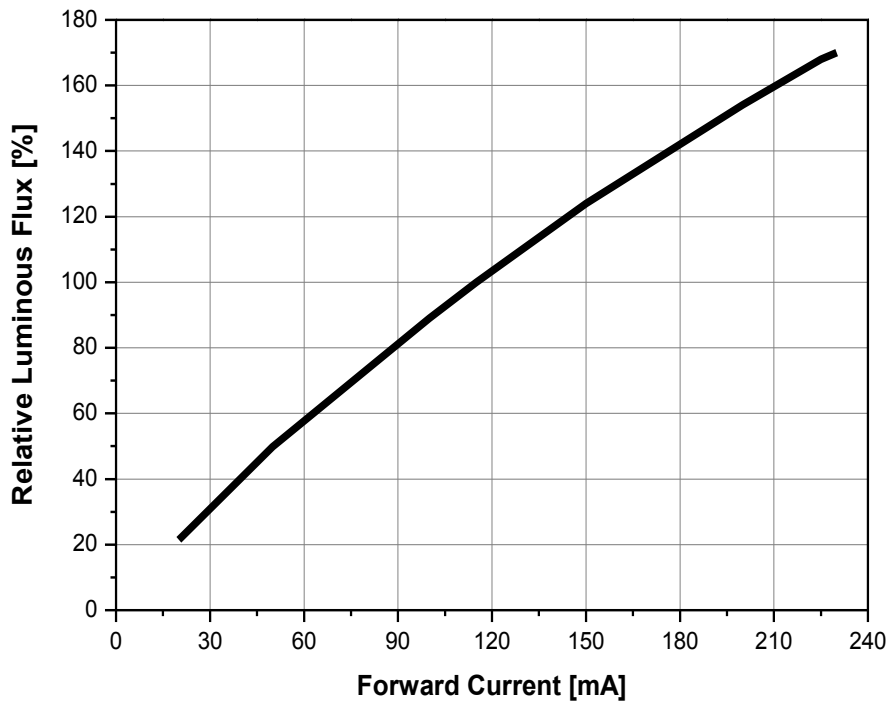
## Characteristics Graph

**Forward Current vs. Relative Luminous Flux,  $T_j=85^\circ\text{C}$  (6V)**



(Fig 4-2)

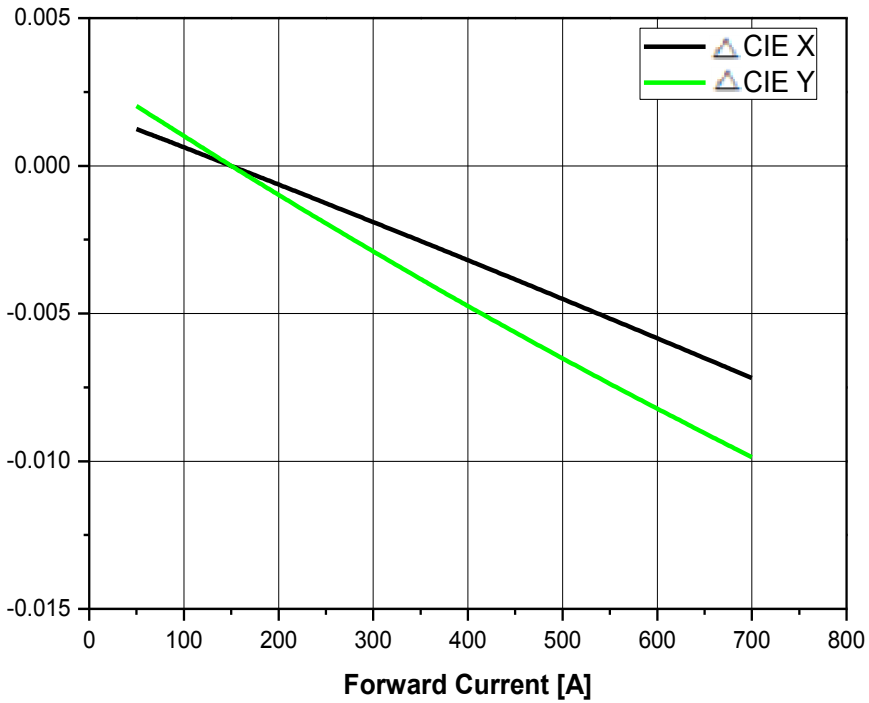
**Forward Current vs. Relative Luminous Flux,  $T_j=85^\circ\text{C}$  (9V)**



(Fig 4-3)

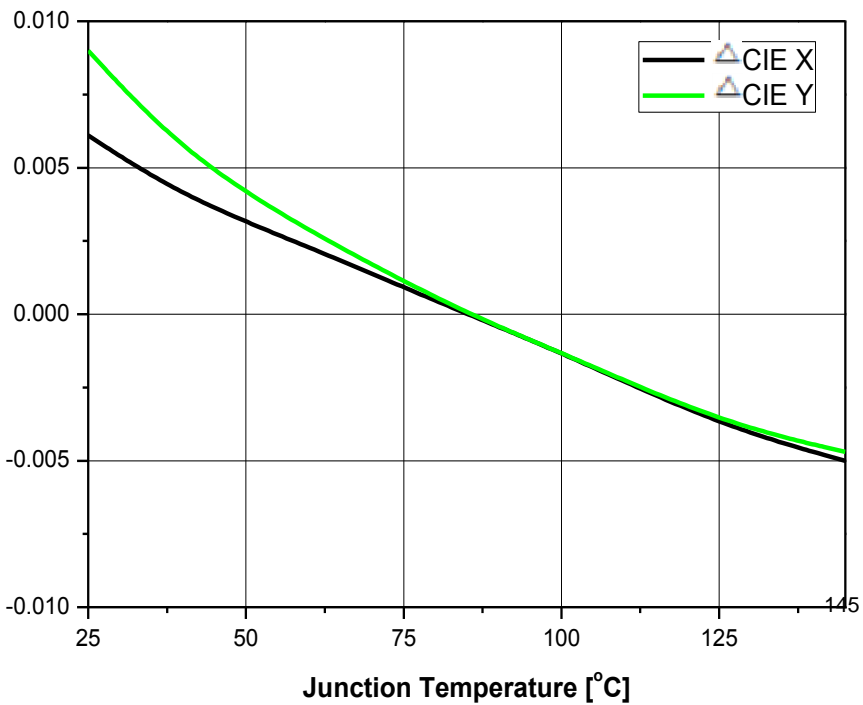
## Characteristics Graph

Forward Current vs. CIE X, Y Shift



(Fig 5)

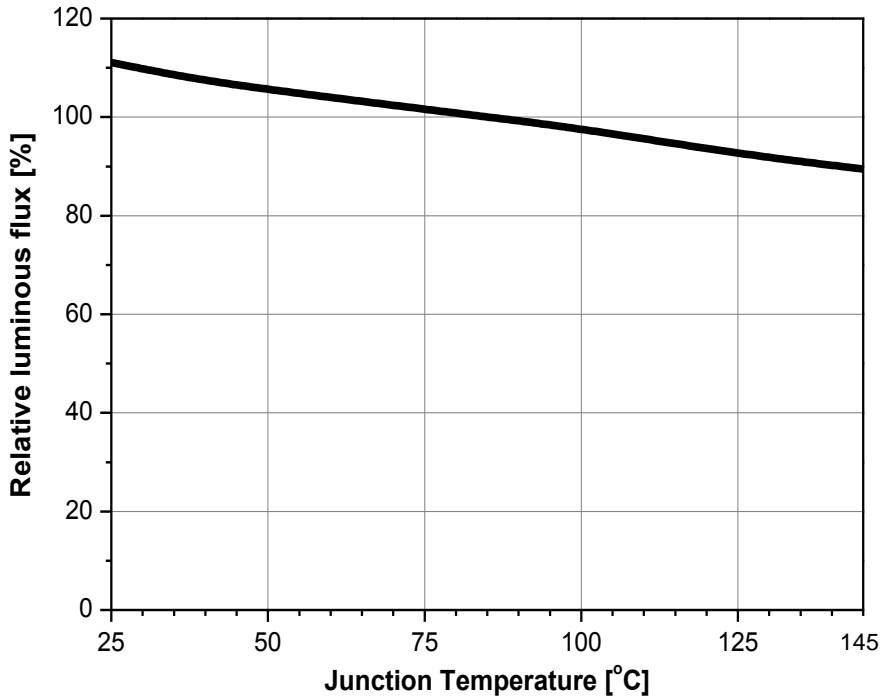
Junction Temp. vs. CIE X, Y Shift



(Fig 6)

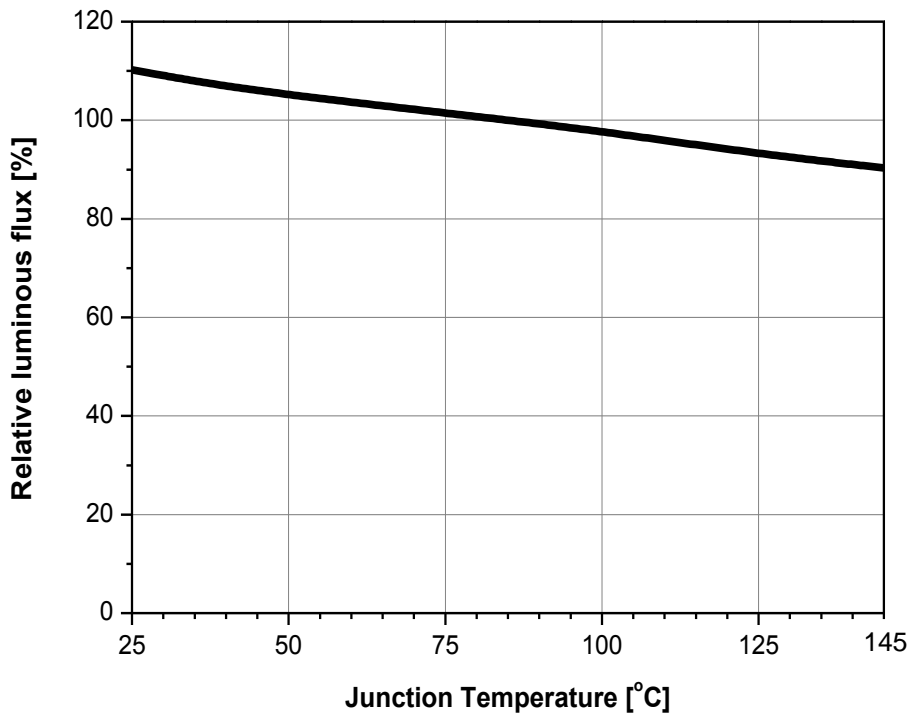
## Characteristics Graph

Relative Light Output vs. Junction Temperature,  $I_F=150\text{mA}$  (3V)



(Fig 7-1)

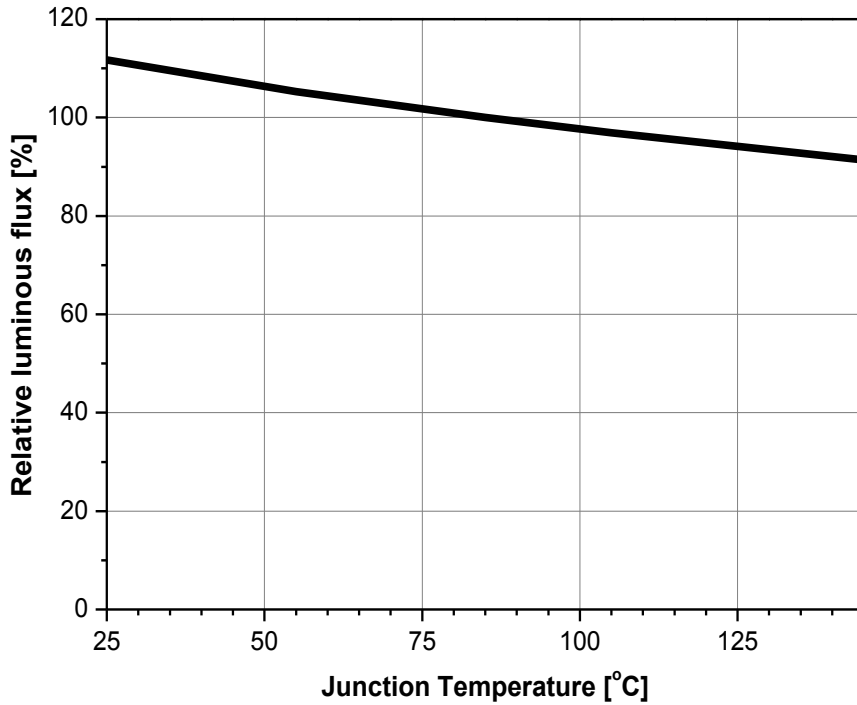
Relative Light Output vs. Junction Temperature,  $I_F=175\text{mA}$  (6V)



(Fig 7-2)

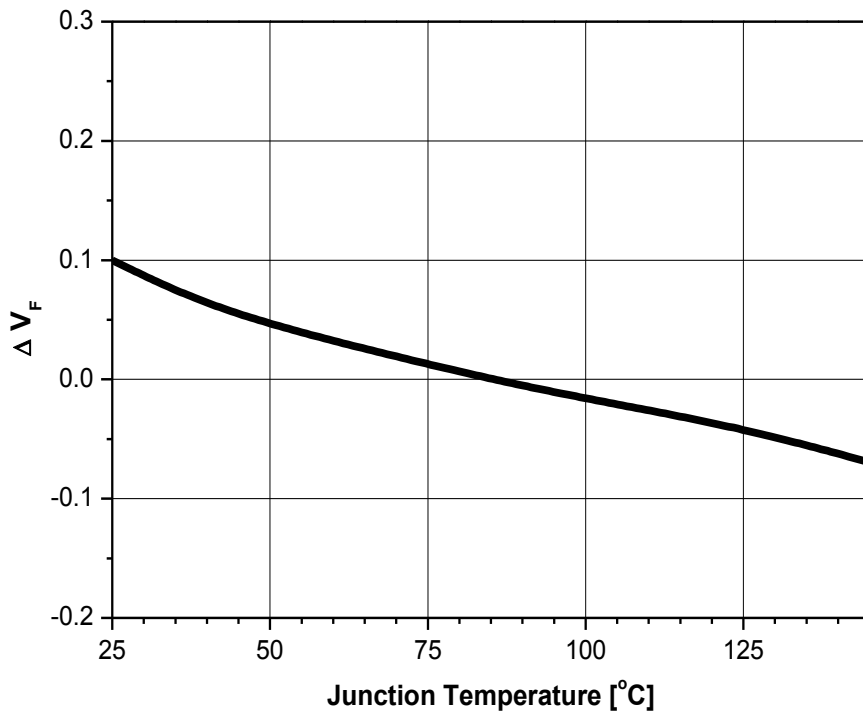
## Characteristics Graph

Relative Light Output vs. Junction Temperature,  $I_F=115\text{mA}$  (9V)



(Fig 7-3)

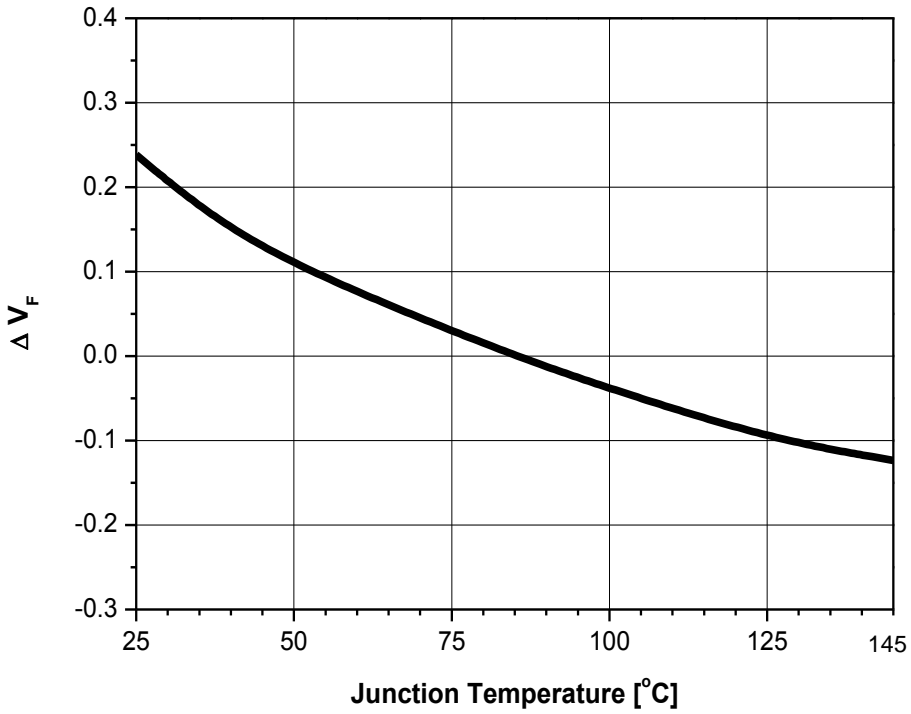
Relative Forward Voltage vs. Junction Temperature,  $I_F=150\text{mA}$  (3V)



(Fig 8-1)

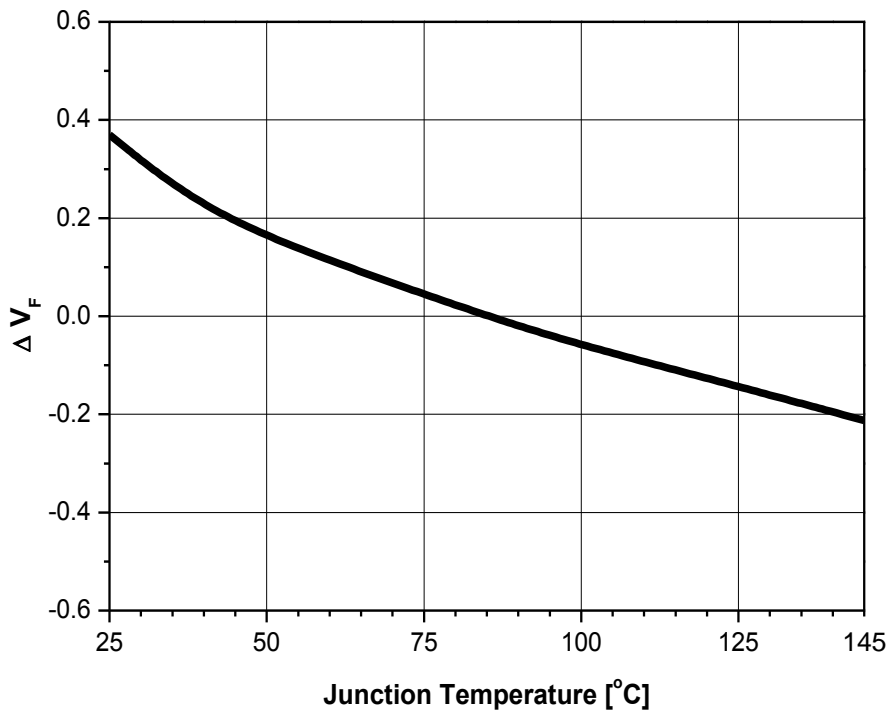
## Characteristics Graph

Relative Forward Voltage vs. Junction Temperature,  $I_F=175\text{mA}$  (6V)



(Fig 8-2)

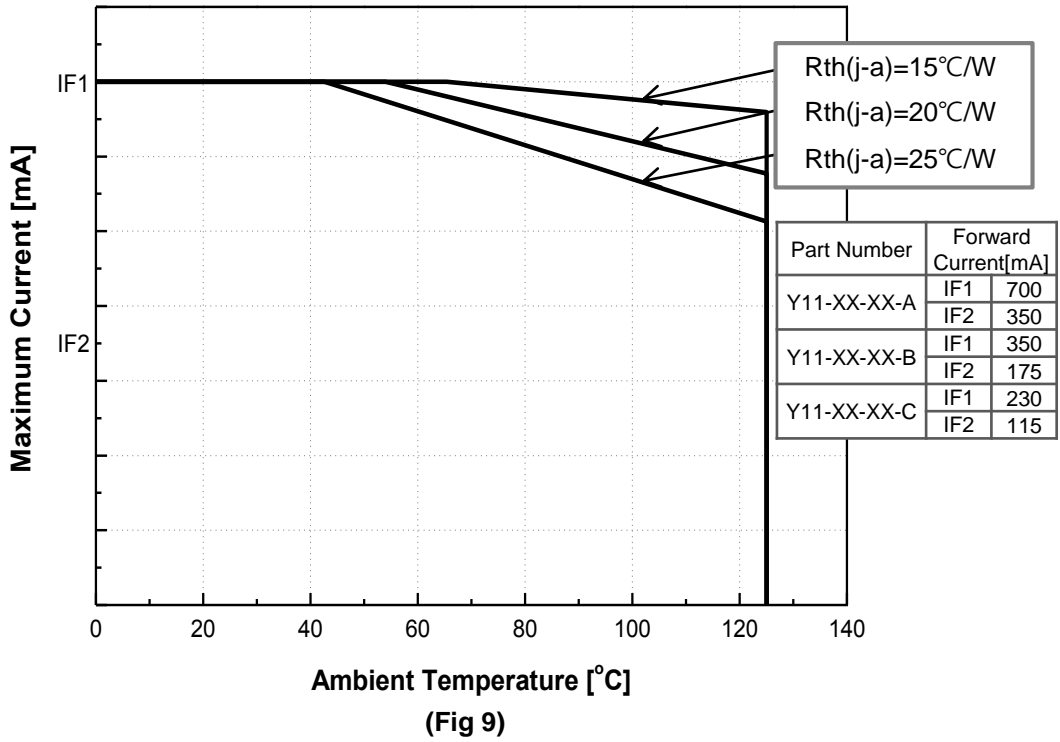
Relative Forward Voltage vs. Junction Temperature,  $I_F=115\text{mA}$  (9V)



(Fig 8-3)

## Characteristics Graph

Maximum Forward Current vs. Ambient Temperature,  $T_j(\text{max.})=145^\circ\text{C}$





## Performance Characteristics

**Table 4-1. Bin Code description,  $I_F=150mA$ ,  $T_j=85^\circ C$  (3V)**

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [ $V_F$ ] <sup>[1]</sup>		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
S1W0-1111XXXX03-00000000-00001	W2	68	73	Refer to page. 20~22	G	2.55	2.80
	W1	64	68				
	V3	60	64				
	V2	56	60				
	V1	52	56		H	2.80	3.05
	U3	49	52				
	U2	46	49				
	U1	43	46				

**Table 5-1. Luminous Flux rank distribution**
Available Rank

CRI	CCT	CIE	Luminous Flux Rank								
70	6,000 ~ 7,000K	A	U1	U2	U3	V1	V2	V3	W1	W2	W3
	5,300 ~ 6,000K	B	U1	U2	U3	V1	V2	V3	W1	W2	W3
	4,700 ~ 5,300K	C	U1	U2	U3	V1	V2	V3	W1	W2	W3
	3,700 ~ 4,200K	E	U1	U2	U3	V1	V2	V3	W1	W2	W3
80	6,000 ~ 7,000K	A	U1	U2	U3	V1	V2	V3	W1	W2	W3
	5,300 ~ 6,000K	B	U1	U2	U3	V1	V2	V3	W1	W2	W3
	4,700 ~ 5,300K	C	U1	U2	U3	V1	V2	V3	W1	W2	W3
	3,700 ~ 4,200K	E	U1	U2	U3	V1	V2	V3	W1	W2	W3
	3,200 ~ 3,700K	F	U1	U2	U3	V1	V2	V3	W1	W2	W3
	2,900 ~ 3,200K	G	U1	U2	U3	V1	V2	V3	W1	W2	W3
	2,600 ~ 2,900K	H	U1	U2	U3	V1	V2	V3	W1	W2	W3
90	6,000 ~ 7,000K	A	U1	U2	U3	V1	V2	V3	W1	W2	W3
	5,300 ~ 6,000K	B	U1	U2	U3	V1	V2	V3	W1	W2	W3
	4,700 ~ 5,300K	C	U1	U2	U3	V1	V2	V3	W1	W2	W3
	3,700 ~ 4,200K	E	U1	U2	U3	V1	V2	V3	W1	W2	W3
	3,200 ~ 3,700K	F	U1	U2	U3	V1	V2	V3	W1	W2	W3
	2,900 ~ 3,200K	G	U1	U2	U3	V1	V2	V3	W1	W2	W3
	2,600 ~ 2,900K	H	U1	U2	U3	V1	V2	V3	W1	W2	W3

**Notes :**

- (1) Tolerance is  $\pm 0.06V$  on forward voltage measurements.
- (2) All measurements were made under the standardized environment of Seoul Semiconductor. In order to ensure availability, single color rank will not be orderable.

## Performance Characteristics

**Table 4-2. Bin Code description,  $I_F=175mA$ ,  $T_J=85^\circ C$  (6V)**

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [ $V_F$ ] <sup>(1)</sup>		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
S1WM-1111XXXX06-00000000-00001	V3	125	133	Refer to page. 20~22	H	5.60	5.90
	V2	116	125				
	V1	109	116				
	U3	102	109		I	5.90	6.20
	U2	96	102				
	U1	89	96				

**Table 5-2. Luminous Flux rank distribution**

Available Rank

CRI	CCT	CIE	Luminous Flux Rank						
			U2	U3	V1	V2	V3	W1	W2
80	6,000 ~ 7,000K	A	U2	U3	V1	V2	V3	W1	W2
	5,300 ~ 6,000K	B	U2	U3	V1	V2	V3	W1	W2
	4,700 ~ 5,300K	C	U2	U3	V1	V2	V3	W1	W2
	3,700 ~ 4,200K	E	U2	U3	V1	V2	V3	W1	W2
	3,200 ~ 3,700K	F	U2	U3	V1	V2	V3	W1	W2
	2,900 ~ 3,200K	G	U2	U3	V1	V2	V3	W1	W2
	2,600 ~ 2,900K	H	U2	U3	V1	V2	V3	W1	W2
90	3,200 ~ 3,700K	F	U2	U3	V1	V2	V3	W1	W2
	2,900 ~ 3,200K	G	U2	U3	V1	V2	V3	W1	W2
	2,600 ~ 2,900K	H	U2	U3	V1	V2	V3	W1	W2

**Notes :**

- (1) All measurements were made under the standardized environment of Seoul Semiconductor  
In order to ensure availability, single color rank will not be orderable.

## Performance Characteristics

**Table 4-3. Bin Code description,  $I_F=115mA$ ,  $T_J=85^\circ C$  (9V)**

Part Number	Luminous Flux [lm]			Color Chromaticity Coordinate	Typical Forward Voltage [ $V_F$ ] <sup>(1)</sup>		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
S1WM-1111XXXX09-00000000-00001	V3	125	133	Refer to page. 20~22	H	8.50	8.80
	V2	116	125				
	V1	109	116				
	U3	102	109		I	8.80	9.15
	U2	96	102				
	U1	89	96				

**Table 5-3. Luminous Flux rank distribution**

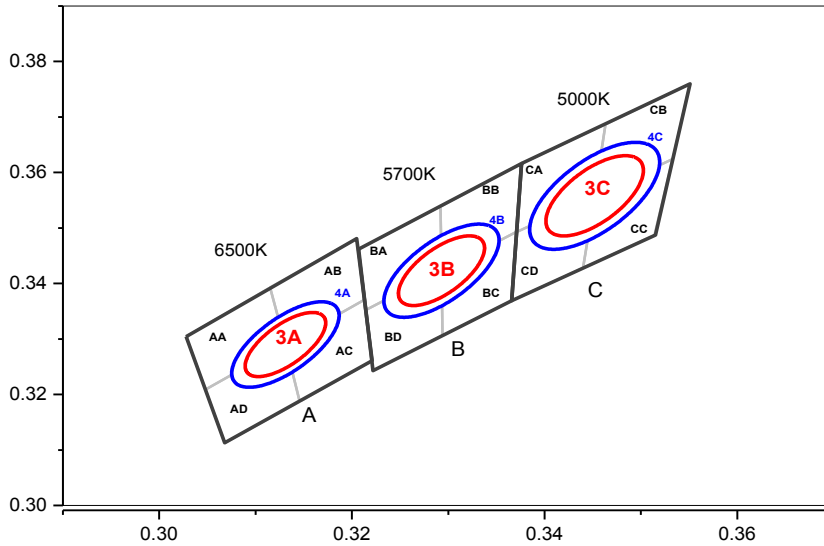
Available Rank

CRI	CCT	CIE	Luminous Flux Rank						
80	6,000 ~ 7,000K	A	U2	U3	V1	V2	V3	W1	W2
	5,300 ~ 6,000K	B	U2	U3	V1	V2	V3	W1	W2
	4,700 ~ 5,300K	C	U2	U3	V1	V2	V3	W1	W2
	3,700 ~ 4,200K	E	U2	U3	V1	V2	V3	W1	W2
	3,200 ~ 3,700K	F	U2	U3	V1	V2	V3	W1	W2
	2,900 ~ 3,200K	G	U2	U3	V1	V2	V3	W1	W2
	2,600 ~ 2,900K	H	U2	U3	V1	V2	V3	W1	W2
90	3,200 ~ 3,700K	F	U2	U3	V1	V2	V3	W1	W2
	2,900 ~ 3,200K	G	U2	U3	V1	V2	V3	W1	W2
	2,600 ~ 2,900K	H	U2	U3	V1	V2	V3	W1	W2

**Notes :**

- (1) All measurements were made under the standardized environment of Seoul Semiconductor  
In order to ensure availability, single color rank will not be orderable.

## Color Bin Structure

**CIE Chromaticity Diagram (Cool White),  $T_j=85^\circ\text{C}$** 


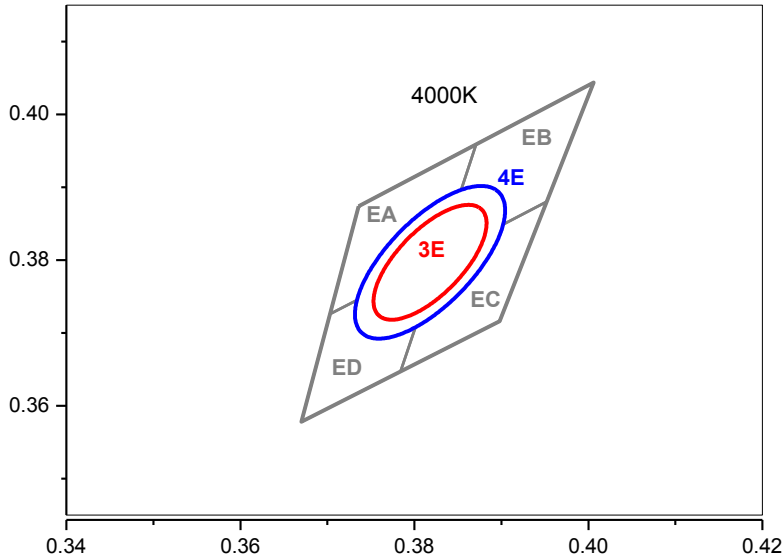
6500K 3Step		5700K 3Step		5000K 3Step	
3A		3B		3C	
Center point	0.3123 : 0.3282	Center point	0.3287 : 0.3417	Center point	0.3447 : 0.3553
Major Axis a	0.0066	Major Axis a	0.0071	Major Axis a	0.0081
Minor Axis b	0.0027	Minor Axis b	0.0030	Minor Axis b	0.0035
Ellipse	58	Ellipse	59	Ellipse	60
Rotation Angle		Rotation Angle		Rotation Angle	

6500K 4Step		5700K 4Step		5000K 4Step	
4A		4B		4C	
Center point	0.3123 : 0.3282	Center point	0.3287 : 0.3417	Center point	0.3447 : 0.3553
Major Axis a	0.0088	Major Axis a	0.0095	Major Axis a	0.0108
Minor Axis b	0.0036	Minor Axis b	0.0040	Minor Axis b	0.0047
Ellipse	58	Ellipse	59	Ellipse	60
Rotation Angle		Rotation Angle		Rotation Angle	

AA		AB		AC		AD	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3028	0.3304	0.3115	0.3393	0.3131	0.329	0.3048	0.3209
0.3048	0.3209	0.3131	0.329	0.3146	0.3187	0.3068	0.3113
0.3131	0.329	0.3213	0.3371	0.3221	0.3261	0.3146	0.3187
0.3115	0.3393	0.3205	0.3481	0.3213	0.3371	0.3131	0.329
BA		BB		BC		BD	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3207	0.3462	0.3292	0.3539	0.3293	0.3423	0.3215	0.3353
0.3215	0.3353	0.3293	0.3423	0.3294	0.3306	0.3222	0.3243
0.3293	0.3423	0.3371	0.3493	0.3366	0.3369	0.3294	0.3306
0.3292	0.3539	0.3376	0.3616	0.3371	0.3493	0.3293	0.3423
CA		CB		CC		CD	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3376	0.3616	0.3463	0.3687	0.3452	0.3558	0.3371	0.3493
0.3371	0.3493	0.3452	0.3558	0.344	0.3428	0.3366	0.3369
0.3452	0.3558	0.3533	0.3624	0.3514	0.3487	0.344	0.3428
0.3463	0.3687	0.3551	0.376	0.3533	0.3624	0.3452	0.3558

## Color Bin Structure

CIE Chromaticity Diagram (Neutral White),  $T_j=85^\circ\text{C}$



### 4000K 3Step

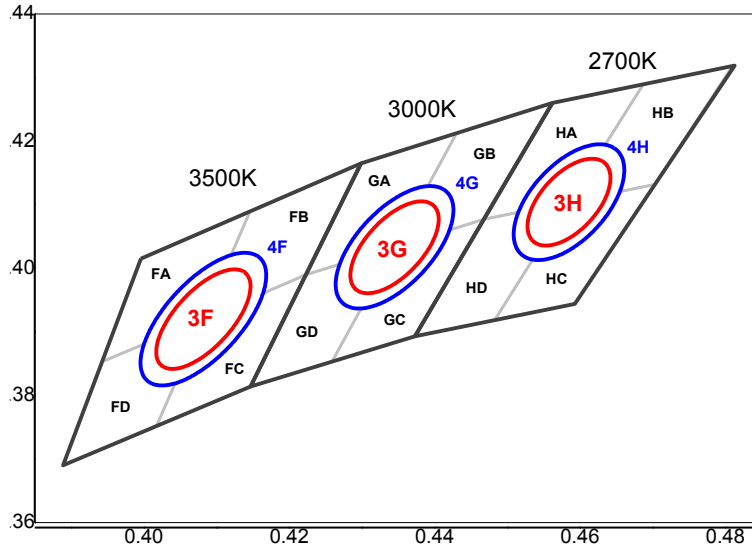
3E	
Center point	0.3818 : 0.3797
Major Axis a	0.0094
Minor Axis b	0.0040
Ellipse	53
Rotation Angle	

### 4000K 4Step

4E	
Center point	0.3818 : 0.3797
Major Axis a	0.0125
Minor Axis b	0.0053
Ellipse	53
Rotation Angle	

EA		EB		EC		ED	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3736	0.3874	0.3871	0.3959	0.3828	0.3803	0.3703	0.3726
0.3703	0.3726	0.3828	0.3803	0.3784	0.3647	0.367	0.3578
0.3828	0.3803	0.3952	0.388	0.3898	0.3716	0.3784	0.3647
0.3871	0.3959	0.4006	0.4044	0.3952	0.388	0.3828	0.3803

## Color Bin Structure

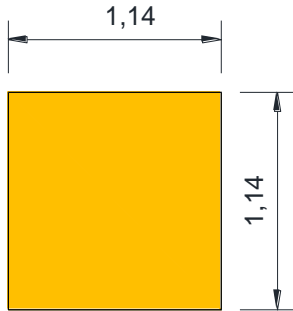
**CIE Chromaticity Diagram (Warm White),  $T_j=85^\circ\text{C}$** 


3500K 3Step		3000K 3Step		2700K 3Step	
3F		3G		3H	
Center point	0.4073 : 0.3917	Center point	0.4338 : 0.4030	Center point	0.4578 : 0.4101
Major Axis a	0.0093	Major Axis a	0.0085	Major Axis a	0.0079
Minor Axis b	0.0041	Minor Axis b	0.0041	Minor Axis b	0.0041
Ellipse	53	Ellipse	53	Ellipse	54
Rotation Angle		Rotation Angle		Rotation Angle	

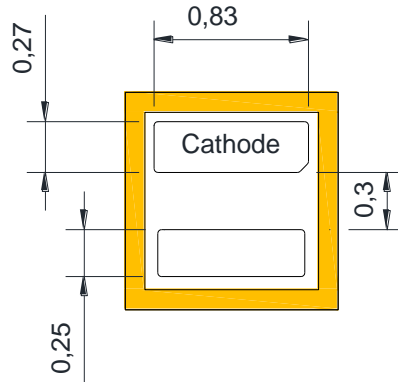
3500K 4Step		3000K 4Step		2700K 4Step	
4F		4G		4H	
Center point	0.4073 : 0.3917	Center point	0.4338 : 0.4030	Center point	0.4578 : 0.4101
Major Axis a	0.0124	Major Axis a	0.0113	Major Axis a	0.0105
Minor Axis b	0.0055	Minor Axis b	0.0055	Minor Axis b	0.0055
Ellipse	53	Ellipse	53	Ellipse	54
Rotation Angle		Rotation Angle		Rotation Angle	

FA		FB		FC		FD	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.3996	0.4015	0.4146	0.4089	0.4082	0.392	0.3943	0.3853
0.3943	0.3853	0.4082	0.392	0.4017	0.3751	0.3889	0.369
0.4082	0.392	0.4223	0.399	0.4147	0.3814	0.4017	0.3751
0.4146	0.4089	0.4299	0.4165	0.4223	0.399	0.4082	0.392
GA		GB		GC		GD	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.4299	0.4165	0.443	0.4212	0.4345	0.4033	0.4223	0.399
0.4223	0.399	0.4345	0.4033	0.4259	0.3853	0.4147	0.3814
0.4345	0.4033	0.4468	0.4077	0.4373	0.3893	0.4259	0.3853
0.443	0.4212	0.4562	0.426	0.4468	0.4077	0.4345	0.4033
HA		HB		HC		HD	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.4562	0.426	0.4687	0.4289	0.4585	0.4104	0.4468	0.4077
0.4468	0.4077	0.4585	0.4104	0.4483	0.3919	0.4373	0.3893
0.4585	0.4104	0.4703	0.4132	0.4593	0.3944	0.4483	0.3919
0.4687	0.4289	0.481	0.4319	0.4703	0.4132	0.4585	0.4104

## Mechanical Dimensions



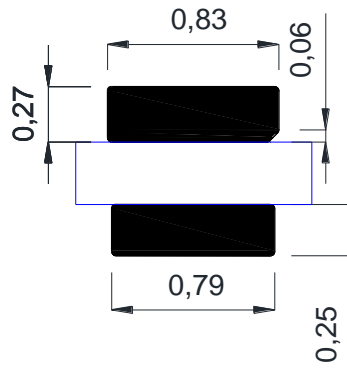
< Top >



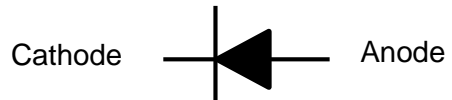
< Bottom >



< Side >



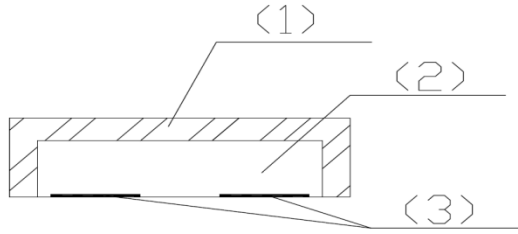
< Recommended Solder Pattern >



< Inner circuit >

- (1) All dimensions are in millimeters.
- (2) Scale : none
- (3) Undefined tolerance is  $\pm 0.13\text{mm}$

## Material Structure



No.	List	Material
①	Encapsulation	Silicone, Phosphor
②	Chip Source	GaN ON SAPPHIRE
③	Solder-PAD	Metal (Au)

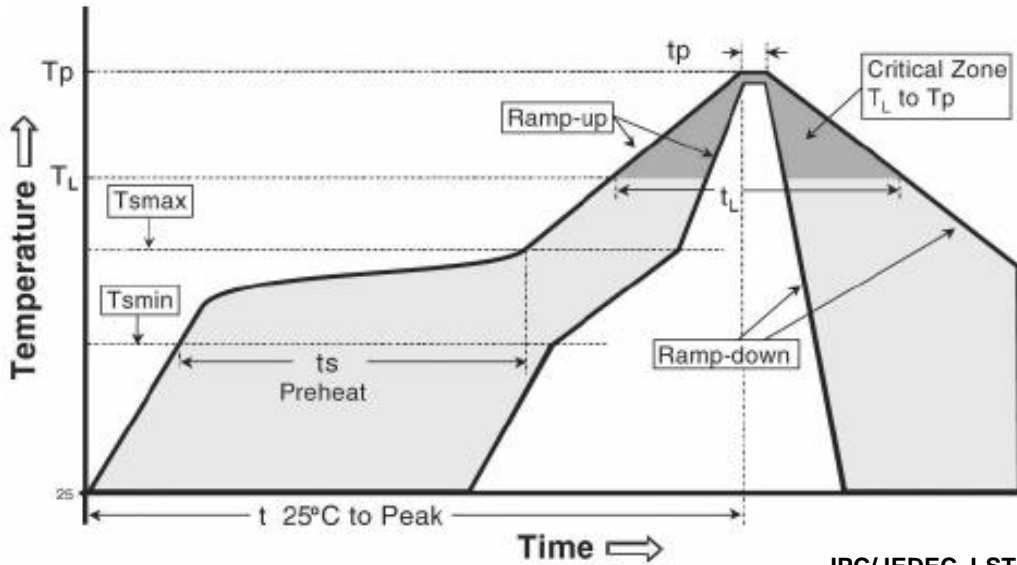


## Product Nomenclature

**Table 6. Part Numbering System : X<sub>1</sub>X<sub>2</sub>X<sub>3</sub>X<sub>4</sub>X<sub>5</sub>X<sub>6</sub>X<sub>7</sub>X<sub>8</sub>-X<sub>9</sub>**

Part Number Code	Description	Part Number	Value
X <sub>1</sub>	Company	S	Seoul Semiconductor
X <sub>2</sub>	Level of Integration	1	Discrete LED
X <sub>3</sub> X <sub>4</sub>	Technology	WX	W0: White General WM: White MJT
X <sub>5</sub> X <sub>6</sub> X <sub>7</sub> X <sub>8</sub>	Dimension	1111	1.14x1.14mm
X <sub>9</sub> X <sub>10</sub>	CCT	XX	65: 6500K 57: 5700K 50: 5000K 45: 4500K 40: 4000K 35: 3500K 30: 3000K 27: 2700K
X <sub>11</sub> X <sub>12</sub>	CRI	XX	70: CRI70 80: CRI80 90: CRI90
X <sub>13</sub> X <sub>14</sub>	Vf	XX	03: 3V 06: 6V 09: 9V
X <sub>15</sub> X <sub>16</sub> X <sub>17</sub>	Characteristic code Flux Rank	000	
X <sub>18</sub> X <sub>19</sub> X <sub>20</sub>	Characteristic code Vf Rank	000	
X <sub>21</sub> X <sub>22</sub>	Characteristic code Color Step	00	
X <sub>23</sub> X <sub>24</sub>	Type	00	
X <sub>25</sub> X <sub>26</sub> X <sub>27</sub>	Internal code	001	

## Reflow Soldering Characteristics


**IPC/JEDEC J-STD-020**

Profile Feature	Pb-Free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3° C/second max.
Preheat - Temperature Min (T <sub>smin</sub> ) - Temperature Max (T <sub>smax</sub> ) - Time (T <sub>smin</sub> to T <sub>smax</sub> ) (t <sub>s</sub> )	150 °C 180 °C 80-120 seconds
Time maintained above: - Temperature (T <sub>L</sub> ) - Time (t <sub>L</sub> )	217~220°C 80-100 seconds
Peak Temperature (T <sub>p</sub> )	250~255°C
Time within 5°C of actual Peak Temperature (t <sub>p</sub> ) <sub>2</sub>	20-40 seconds
Ramp-down Rate	6 °C/second max.
Time 25°C to Peak Temperature	8 minutes max.
Atmosphere	Nitrogen (O <sub>2</sub> <1000ppm)

### Caution

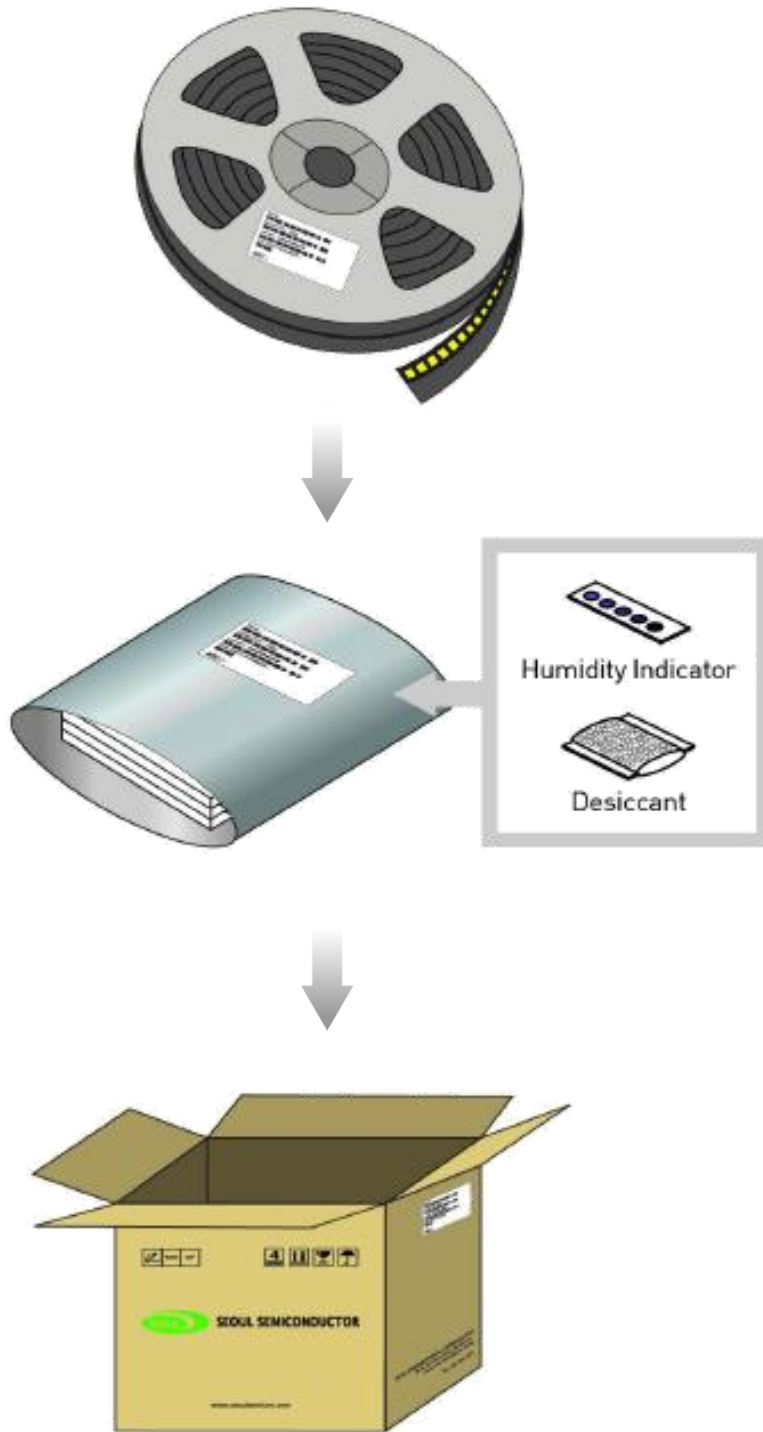
- (1) Reflow soldering is recommended not to be done more than two times. When 24 hours passed after first soldering, following reflow soldering will make LED damaged.
- (2) Re-soldering should not be done after the LED have been soldered. If re-soldering is unavoidable, LED's characteristics should be carefully checked on before and after such repair.
- (3) Do not put stress on the LED during heating.
- (4) After reflow, do not clean PCB with either water or solvent.

### SMT recommendation

- (1) After reflow, Over 80% reflectance of PSR is recommended.
- (2) Solder paste materials (SAC 305, No Cleaning Paste )
- (3) We recommend TOV Test 1.8V~2.8V at 1uA (per LED).
- (4) We recommend IR Test 0~1uA at -5V (per LED) for 3V.  
We recommend TOV Test 6.6V~8.5V at 30uA (per LED) for 9V.



## Packaging Information



## Handling of Silicone Resin for LED

- (1) During processing, mechanical stress on the surface should be minimized as much as possible. Sharp objects of all types should not be used to pierce the sealing compound.



- (2) Do not use tweezers to pick up or handle WICOP2 LED. A vacuum pick up should only be used.
- (3) When populating boards in SMT production, there are basically no restrictions regarding the form of the pick and place nozzle, except that mechanical pressure on the surface of the resin must be prevented. This is assured by choosing a pick and place nozzle which is smaller than the LED's area.
- (4) Silicone differs from materials conventionally used for the manufacturing of LED. These conditions must be considered during the handling of such devices. Compared to standard encapsulants, silicone is generally softer, and the surface is more likely to attract dust. As mentioned previously, the increased sensitivity to dust requires special care during processing.
- (5) Please do not mold this product into another resin (epoxy, urethane, etc) and do not handle this product with acid or sulfur material in sealed space.
- (6) Avoid leaving fingerprints on silicone resin parts.

## Precaution for Use

### (1) Storage

To avoid the moisture penetration, we recommend storing LED in a dry box with a desiccant . The recommended storage temperature range is 5°C to 30°C and a maximum humidity of RH50%.

### (2) Use Precaution after Opening the Packaging

Use SMT techniques properly when you solder the LED as separation of the lens may affect the light output efficiency.

Pay attention to the following:

a. Recommend conditions after opening the package

- Sealing / Temperature : 5 ~ 30°C Humidity : less than RH60%

b. If the package has been opened more than 1 year (MSL 2) or the color of

the desiccant changes, components should be dried for 10-24hr at 65±5°C

(3) Do not apply mechanical force or excess vibration during the cooling process to normal temperature after soldering.

(4) Do not rapidly cool device after soldering.

(5) Components should not be mounted on warped (non coplanar) portion of PCB.

(6) Radioactive exposure is not considered for the products listed here in.

(7) Gallium arsenide is used in some of the products listed in this publication. These products are dangerous if they are burned or shredded in the process of disposal. It is also dangerous to drink the liquid or inhale the gas generated by such products when chemically disposed of.

(8) This device should not be used in any type of fluid such as water, oil, organic solvent and etc.

(9) When the LED are in operation the maximum current should be decided after measuring the package temperature.

(10) The appearance and specifications of the product may be modified for improvement without notice.

(11) Long time exposure of sunlight or occasional UV exposure will cause lens discoloration.

## Precaution for Use

(12) VOCs (Volatile organic compounds) emitted from materials used in the construction of fixtures can penetrate silicone encapsulants of LED and discolor when exposed to heat and photonic energy. The result can be a significant loss of light output from the fixture. Knowledge of the properties of the materials selected to be used in the construction of fixtures can help prevent these issues.

(13) Attaching LED, do not use adhesives that outgas organic vapor.

(14) The driving circuit must be designed to allow forward voltage only when it is ON or OFF. If the reverse voltage is applied to LED, migration can be generated resulting in LED damage.

(15) LED are sensitive to Electro-Static Discharge (ESD) and Electrical Over Stress (EOS). Below is a list of suggestions that Seoul Semiconductor purposes to minimize these effects.

### a. ESD (Electro Static Discharge)

Electrostatic discharge (ESD) is defined as the release of static electricity when two objects come into contact. While most ESD events are considered harmless, it can be an expensive problem in many industrial environments during production and storage. The damage from ESD to an LED may cause the product to demonstrate unusual characteristics such as:

- Increase in reverse leakage current lowered turn-on voltage
- Abnormal emissions from the LED at low current

The following recommendations are suggested to help minimize the potential for an ESD event.

One or more recommended work area suggestions:

- Ionizing fan setup
- ESD table/shelf mat made of conductive materials
- ESD safe storage containers

One or more personnel suggestion options:

- Antistatic wrist-strap
- Antistatic material shoes
- Antistatic clothes

Environmental controls:

- Humidity control (ESD gets worse in a dry environment)

## Precaution for Use

### b. EOS (Electrical Over Stress)

Electrical Over-Stress (EOS) is defined as damage that may occur when an electronic device is subjected to a current or voltage that is beyond the maximum specification limits of the device. The effects from an EOS event can be noticed through product performance like:

- Changes to the performance of the LED package  
(If the damage is around the bond pad area and since the package is completely encapsulated the package may turn on but flicker show severe performance degradation.)
- Changes to the light output of the luminaire from component failure
- Components on the board not operating at determined drive power

Failure of performance from entire fixture due to changes in circuit voltage and current across total circuit causing trickle down failures. It is impossible to predict the failure mode of every LED exposed to electrical overstress as the failure modes have been investigated to vary, but there are some common signs that will indicate an EOS event has occurred:

- This damage usually appears due to the thermal stress produced during the EOS event.

### c. To help minimize the damage from an EOS event Seoul Semiconductor recommends utilizing:

- A surge protection circuit
- An appropriately rated over voltage protection device
- A current limiting device





## Company Information

### Published by

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### Company Information

Seoul Semiconductor ([www.SeoulSemicon.com](http://www.SeoulSemicon.com)) manufactures and packages a wide selection of light emitting diodes (LED) for the automotive, general illumination/lighting, Home appliance, signage and back lighting markets. The company is the world's fifth largest LED supplier, holding more than 10,000 patents globally, while offering a wide range of LED technology and production capacity in areas such as "nPola", "Acrich", the world's first commercially produced AC LED, and "Acrich MJT - Multi-Junction Technology" a proprietary family of high-voltage LED.

The company's broad product portfolio includes a wide array of package and device choices such as Acrich and Acirch2, high-brightness LED, mid-power LED, side-view LED, and through-hole type LED as well as custom modules, displays, and sensors.

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